

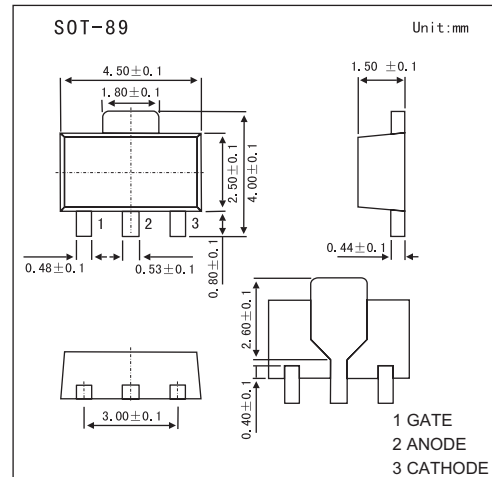
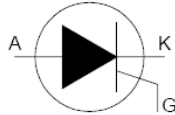
Silicon Controlled Rectifiers

HBT169M

■ Features

- Repetitive peak off-state voltages :400V
- Average on-state current :0.5A
- RMS on-state current :0.8A
- Non-repetitive peak on-state current :8A

Symbol



■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

| Parameter | Symbol | Rating | Unit |
|---|-------------------------------|--------|------------------|
| Peak Repetitive Forward and Reverse Blocking Voltage* | V_{DRM} and V_{RRM} | 400 | V |
| Forward Current RMS | $I_{T(RMS)}$ | 0.8 | A |
| Non-repetitive peak on-state current (t=10ms) | I_{TSM} | 8 | A |
| Non-repetitive peak on-state current (t=8.3ms) | | 9 | A |
| Circuit Fusing Considerations (t = 10ms) | I^2t | 0.32 | A^2s |
| Repetitive rate of rise of on-state current after triggering *1 | di_T/dt | 50 | A/us |
| Peak gate current | I_{GM} | 1 | A |
| Peak Gate Power — Forward, $T_A = 25^\circ\text{C}$ | P_{GM} | 2 | W |
| Average Gate Power — Forward, $T_A = 25^\circ\text{C}$ | $P_{GF(AV)}$ | 0.1 | W |
| Peak Gate Current — Forward, $T_A = 25^\circ\text{C}$ | I_{GFM} | 1 | A |
| Peak gate voltage | V_{GM} | 5 | V |
| Peak Gate Voltage — Reverse | V_{GRM} | 5 | V |
| Thermal resistance junction to lead *2 | $R_{th\ j-lead}$ | 60 | K/W |
| Thermal resistance junction to ambient *2 | $R_{th\ j-a}$ | 150 | K/W |
| Storage temperature | T_{stg} | 150 | $^\circ\text{C}$ |
| Operating junction temperature | T_J | 125 | $^\circ\text{C}$ |

*1 $I_{TM}=2A$; $I_G=10mA$; $di_G/dt=100mA/us$

*2 pcb mounted;lead length=4mm

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■ Electrical Characteristics (Ta = 25°C, unless otherwise noted.)

| Parameter | Symbol | Testconditions | Min | Typ. | Max | Unit |
|--|---------------------------------|--|-----|------|------|------|
| On-state Voltage | V _T | I _T =1A | | 1.2 | 1.35 | V |
| Gate Trigger Current (Continuous dc)*2 T _c = 25°C | I _{GT} | V _D =12V, I _T =10mA, Gate open circuit | | 50 | 200 | μ A |
| Latching Current | I _L | V _D =12V, I _{GT} =0.5mA; R _{GK} =1k Ω | | 2 | 6 | mA |
| Holding Current | I _H | V _D =12V, I _{GT} =0.5mA; R _{GK} =1k Ω | | 2 | 5 | mA |
| Gate Trigger Voltage | V _{GT} | V _D =12V, I _T =10mA, Gate open circuit | | 0.5 | 0.8 | V |
| | | V _D = V _{DRM} (max), I _T =10mA; T _j =125 °C, Gate open circuit | 0.2 | 0.2 | | |
| Off-state Leakage Current | I _D , I _R | V _D =V _{DRM} (max); V _R = V _{RRM} (max); T _j =125 °C; R _{GK} =1k Ω | | 0.05 | 0.1 | mA |
| Critical rate of rise of off-state voltage | dV _D /dt | V _{DM} =67% V _{DRM} (max); T _j =125 °C, exponential waveform; R _{GK} =1k Ω | 500 | 800 | | V/us |
| Gate controlled turn-on time | t _{gt} | I _{TM} =2A; V _D =V _{DRM} (max), G=10mA; di _G /dt=0.1A/us | | 2 | | us |
| Circuit commutated turn-off time | t _q | V _D =67% V _{DRM} (max); T _j =125 °C, T _M =1.6A; V _R =35V; di _{TM} /dt=30A/us, dv _D /dt=2V/us; R _{GK} =1k Ω | | 100 | | us |

*1. Forward current applied for 1 ms maximum duration, duty cycle ≤ 1%.

*2. R_{GK} current is not included in measurement.

■ Marking

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| Marking | 169 |
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